

**Dual N-Channel Enhancement Mode Power MOSFET**

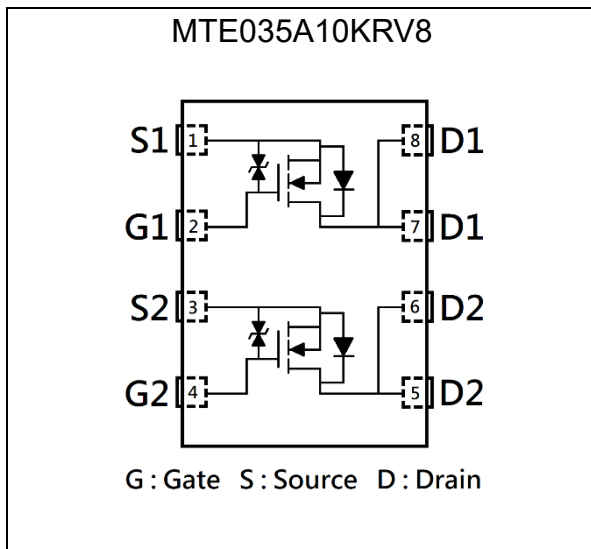
# MTE035A10KRV8

**Features**

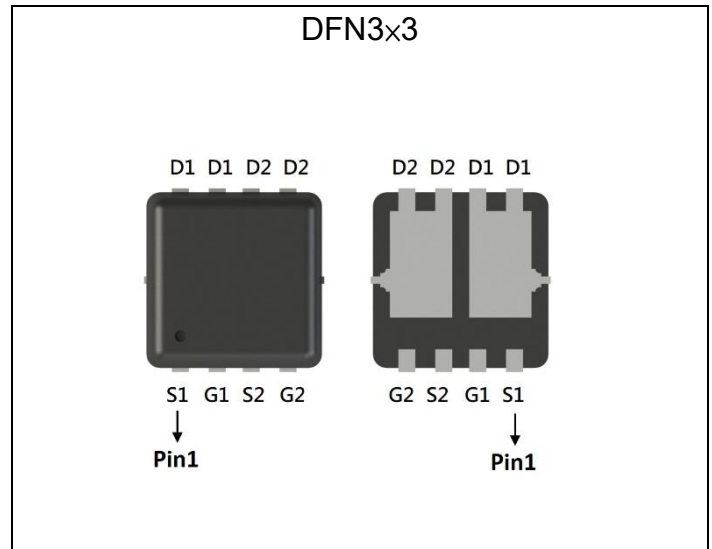
- Low Gate Charge
- Fast Switching Characteristic
- ESD protected gate

|                                      |      |
|--------------------------------------|------|
| $BV_{DSS}$                           | 100V |
| $I_D@V_{GS}=10V, T_C=25^\circ C$     | 9A   |
| $I_D@V_{GS}=10V, T_A=25^\circ C$     | 5.2A |
| $R_{DS(ON) typ.}@V_{GS}=10V, I_D=2A$ | 39mΩ |

**Equivalent Circuit**

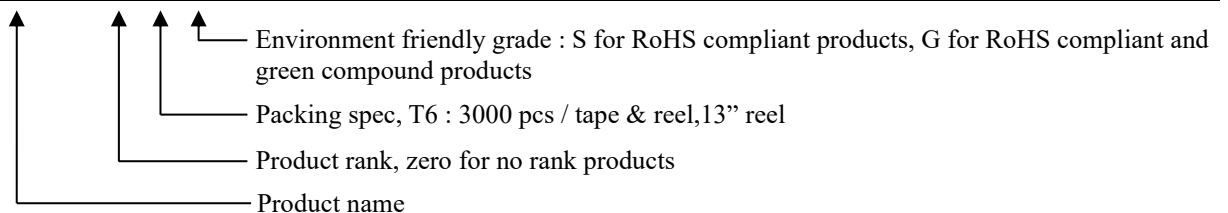


**Outline**



**Ordering Information**

| Device               | Package   | Shipping               |
|----------------------|---|------------------------|
| MTE035A10KRV8-0-T6-G | DFN3x3<br>(Pb-free lead plating and halogen-free package) | 3000 pcs / Tape & Reel |



**Absolute Maximum Ratings (T<sub>A</sub>=25°C)**

| Parameter  | Symbol                            | Limits          | Unit |
|--|-----------------------------------|-----------------|------|
| Drain-Source Voltage   | V <sub>DS</sub>                   | 100             | V    |
| Gate-Source Voltage  | V <sub>GS</sub>                   | ±20             |      |
| Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>C</sub> =25°C (silicon limit) *a | I <sub>D</sub>                    | 16              | A    |
| Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>C</sub> =25°C (package limit) *a |                                   | 9               |      |
| Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>C</sub> =100°C *a                |                                   | 9               |      |
| Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>A</sub> =25°C *b                 |                                   | 5.2             |      |
| Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>A</sub> =70°C *b                 |                                   | 4.2             |      |
| Pulsed Drain Current *c  |                                   | I <sub>DM</sub> |      |
| Continuous Body Diode Forward Current @ T <sub>C</sub> =25°C *a                          | I <sub>S</sub>                    | 9               | mJ   |
| Pulsed Body Diode Forward Current @ T <sub>C</sub> =25°C *a                              | I <sub>SM</sub>                   | 36              |      |
| Avalanche Current @ L=0.1mH  | I <sub>AS</sub>                   | 5               |      |
| Avalanche Energy @ L=0.5mH   | E <sub>AS</sub>                   | 6               | W    |
| Total Power Dissipation  | T <sub>C</sub> =25°C *a           | 26              |      |
|  | T <sub>C</sub> =100°C *a          | 10              |      |
|  | T <sub>A</sub> =25°C *b           | 2.7             |      |
|  | T <sub>A</sub> =70°C *b           | 1.7             |      |
| Operating Junction and Storage Temperature Range   | T <sub>J</sub> , T <sub>stg</sub> | -55~+150        | °C   |

**Thermal Data**

| Parameter                                  | Symbol           | Steady State | Unit |
|--|------------------|--------------|------|
| Thermal Resistance, Junction-to-case       | R <sub>θJC</sub> | 4.8          | °C/W |
| Thermal Resistance, Junction-to-ambient *b | R <sub>θJA</sub> | 46           |      |

Note:

- \*a. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- \*b. The value of R<sub>θJA</sub> is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2 oz. copper, in a still air environment with T<sub>A</sub>=25°C. The power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- \*c. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150°C. Ratings are based on low frequency and low duty cycles to keep initial T<sub>J</sub>=25°C.



**Electrical Characteristics (T<sub>A</sub>=25°C, unless otherwise specified)**

| Symbol                    | Min. | Typ. | Max. | Unit | Test Conditions   |
|---------------------------|------|------|------|------|---|
| <b>Static</b>             |      |      |      |      |   |
| BV <sub>DSS</sub>         | 100  | -    | -    | V    | V <sub>GS</sub> =0V, I <sub>D</sub> =250μA  |
| V <sub>GS(th)</sub>       | 2    | -    | 4    |      | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                            |
| G <sub>FS</sub>           | -    | 3.2  | -    | S    | V <sub>DS</sub> =10V, I <sub>D</sub> =2A  |
| I <sub>GSS</sub>          | -    | -    | ±10  | μA   | V <sub>GS</sub> =±16V, V <sub>DS</sub> =0V  |
| I <sub>DSS</sub>          | -    | -    | 1    |      | V <sub>DS</sub> =80V, V <sub>GS</sub> =0V   |
| R <sub>DS(ON)</sub>       | -    | 39   | 51   | mΩ   | V <sub>GS</sub> =10V, I <sub>D</sub> =2A  |
| <b>Dynamic</b>            |      |      |      |      |   |
| C <sub>iSS</sub>          | -    | 412  | -    | pF   | V <sub>DS</sub> =50V, V <sub>GS</sub> =0V, f=1MHz                                   |
| C <sub>oss</sub>          | -    | 68   | -    |      |   |
| C <sub>rSS</sub>          | -    | 18   | -    |      |   |
| R <sub>g</sub>            | -    | 5.7  | -    | Ω    | f=1MHz  |
| Q <sub>g</sub> *1, 2      | -    | 6.7  | -    | nC   | V <sub>DS</sub> =50V, I <sub>D</sub> =2A, V <sub>GS</sub> =10V                      |
| Q <sub>gs</sub> *1, 2     | -    | 2    | -    |      |   |
| Q <sub>gd</sub> *1, 2     | -    | 1.2  | -    |      |   |
| t <sub>d(ON)</sub> *1, 2  | -    | 8    | -    | ns   | V <sub>DS</sub> =50V, I <sub>D</sub> =2A, V <sub>GS</sub> =10V, R <sub>GS</sub> =1Ω |
| t <sub>r</sub> *1, 2      | -    | 16   | -    |      |   |
| t <sub>d(OFF)</sub> *1, 2 | -    | 17   | -    |      |   |
| t <sub>f</sub> *1, 2      | -    | 14   | -    |      |   |
| <b>Source-Drain Diode</b> |      |      |      |      |   |
| V <sub>SD</sub> *1        | -    | 0.8  | 1.2  | V    | I <sub>S</sub> =2A, V <sub>GS</sub> =0V   |
| t <sub>rr</sub>           | -    | 22   | -    | ns   | I <sub>F</sub> =2A, dI <sub>F</sub> /dt=100A/μs                                     |
| Q <sub>rr</sub>           | -    | 18   | -    | nC   |   |

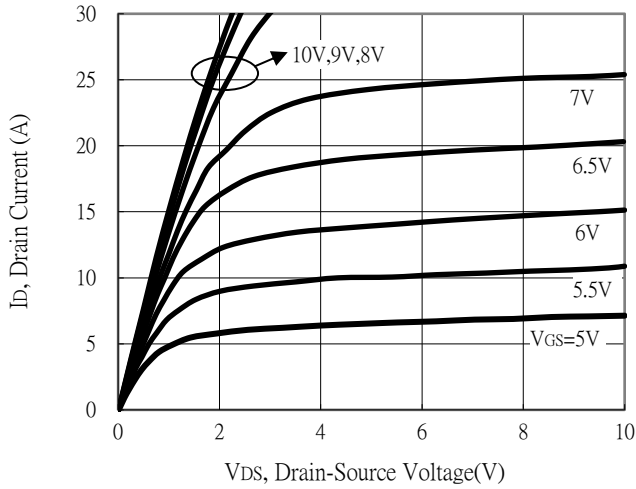
Note:

\*1. Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

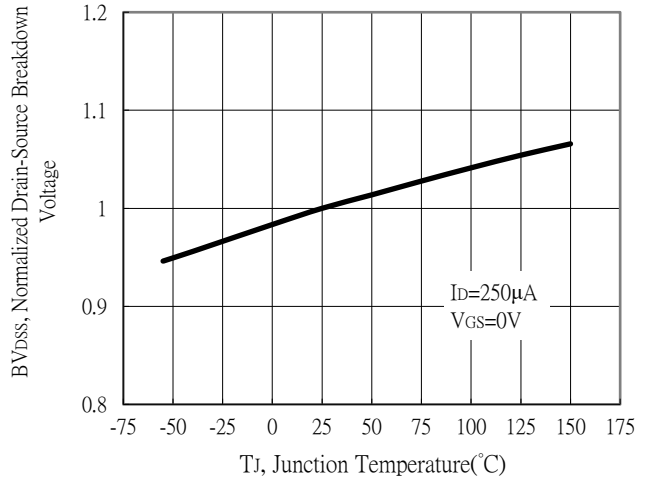
\*2. Independent of operating temperature

## Typical Characteristics

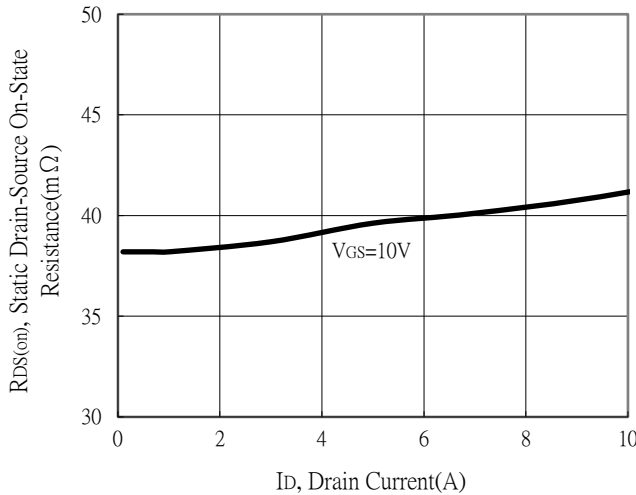
Typical Output Characteristics



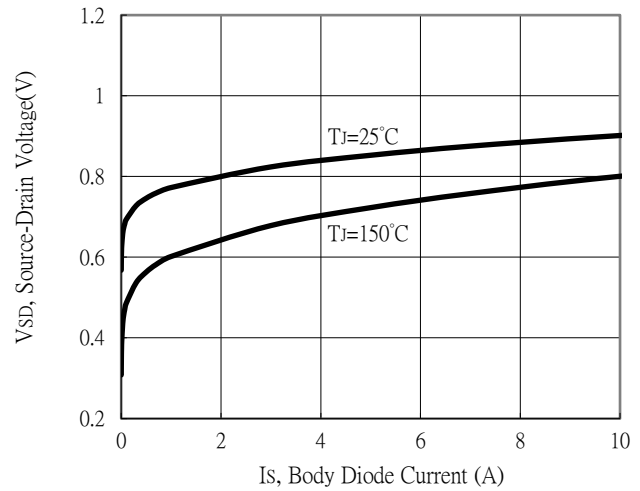
Breakdown Voltage vs Ambient Temperature



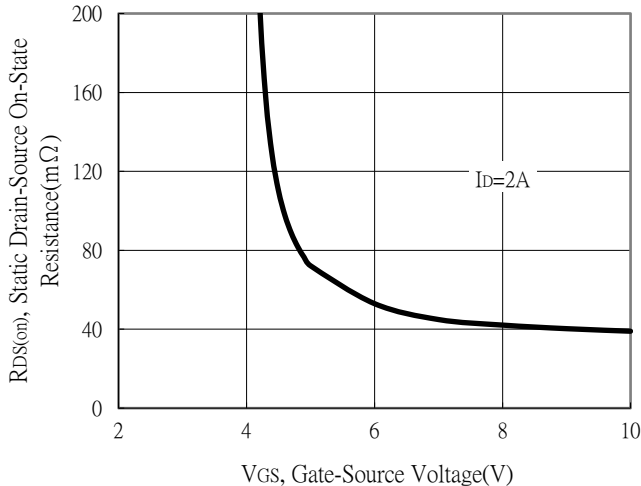
Static Drain-Source On-State resistance vs Drain Current



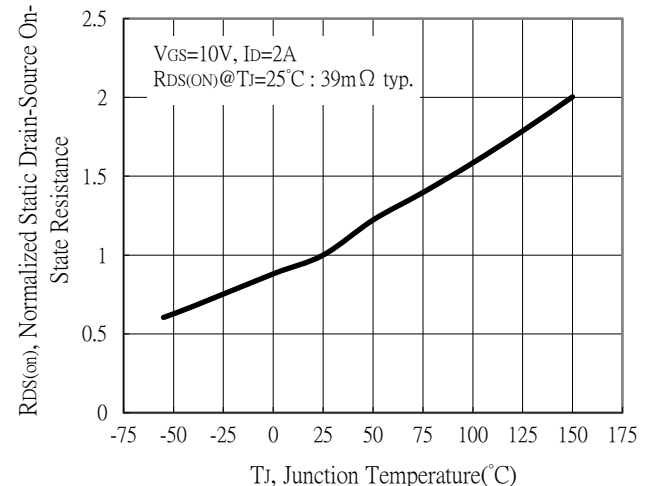
Body Diode Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

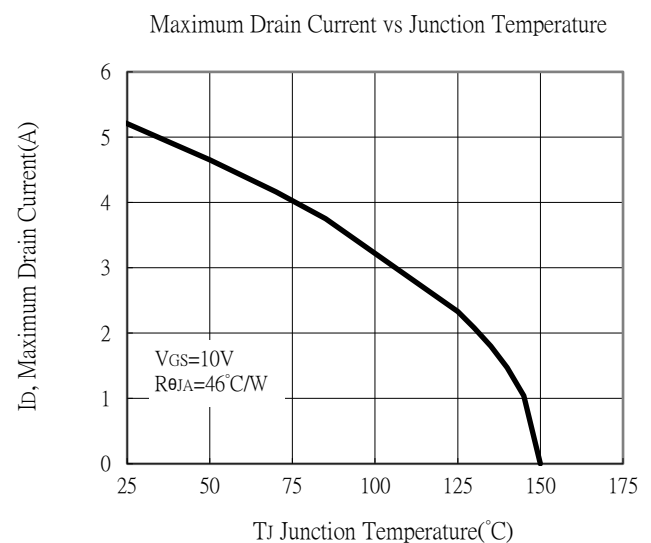
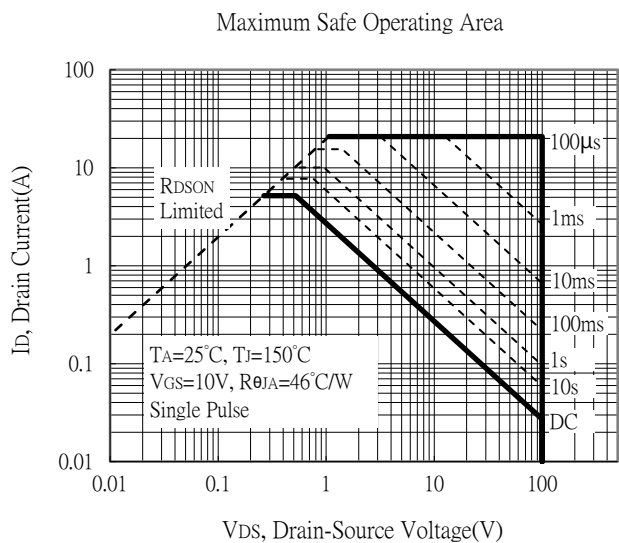
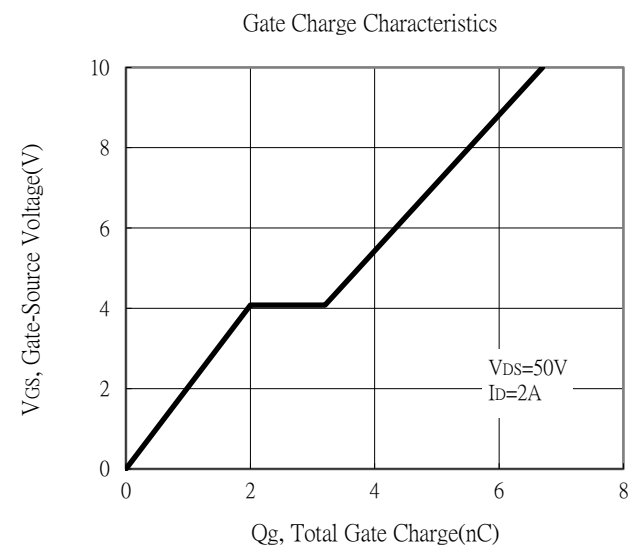
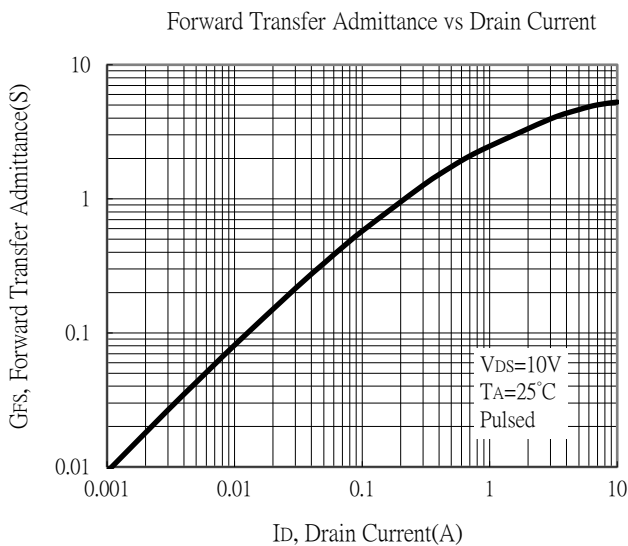
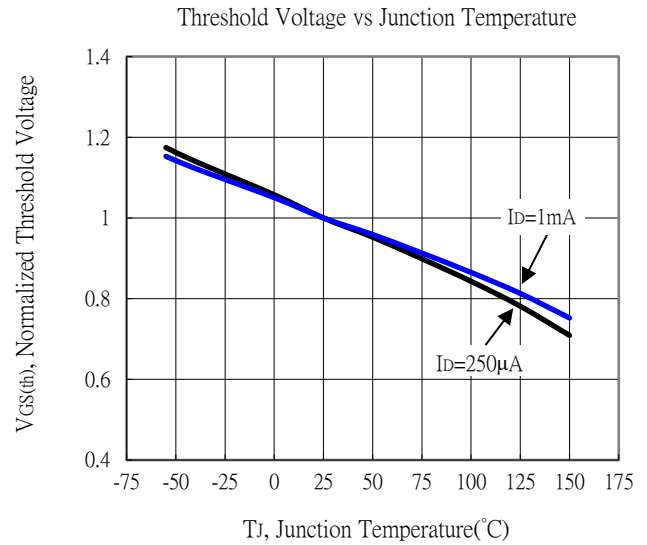
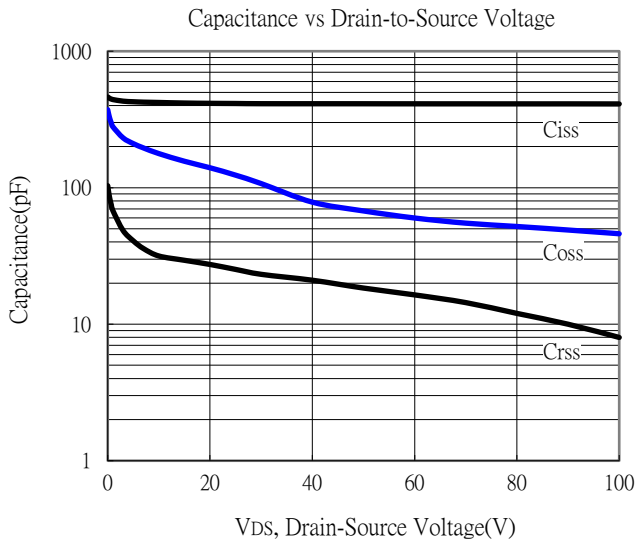


Drain-Source On-State Resistance vs Junction Temperature

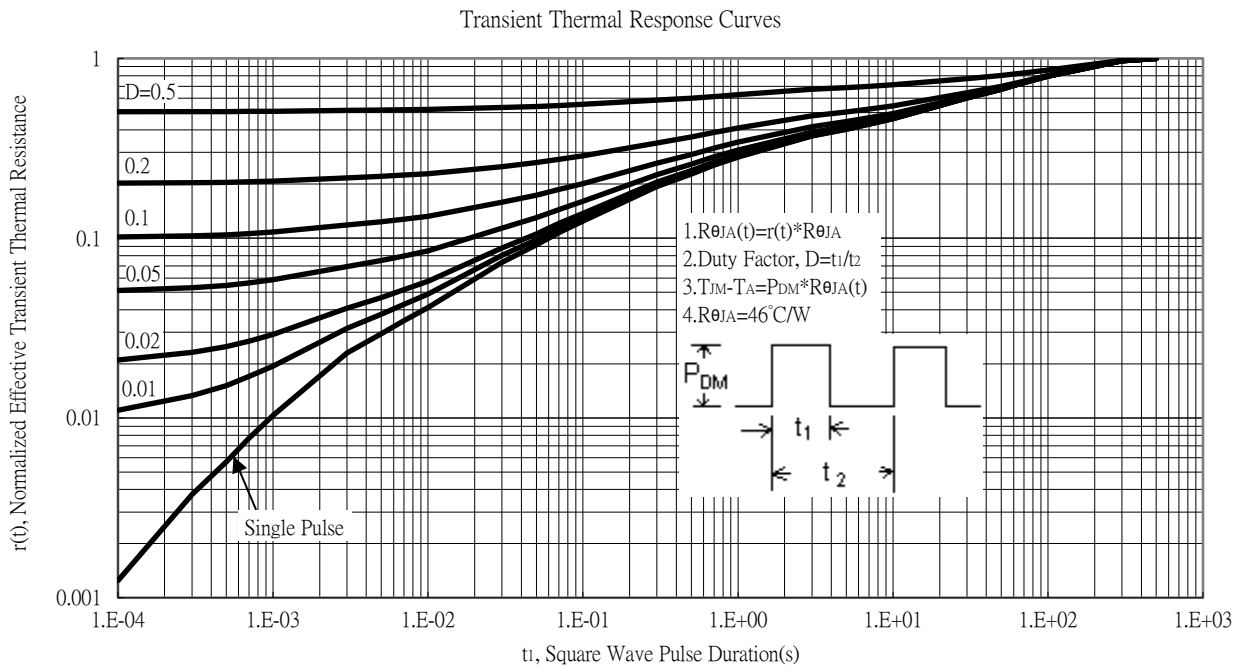
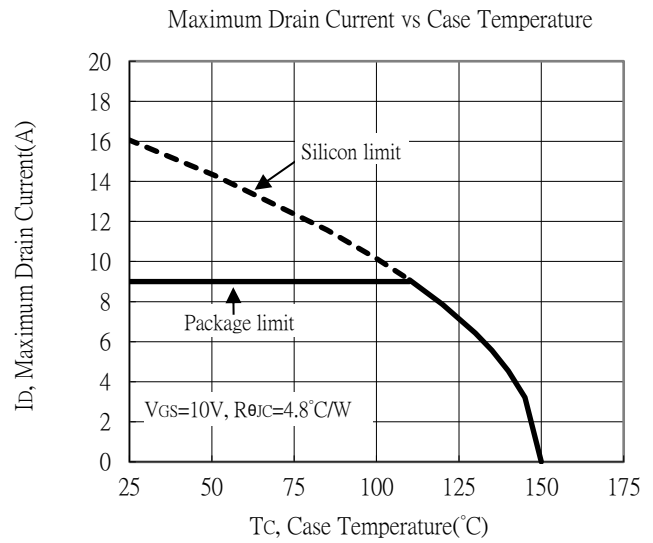
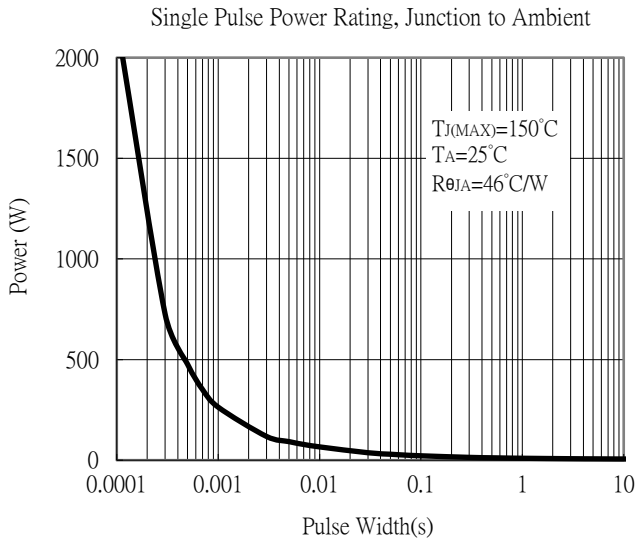




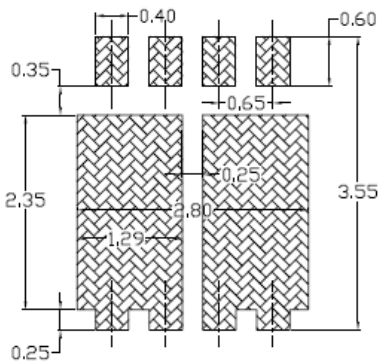
**Typical Characteristics (Cont.)**



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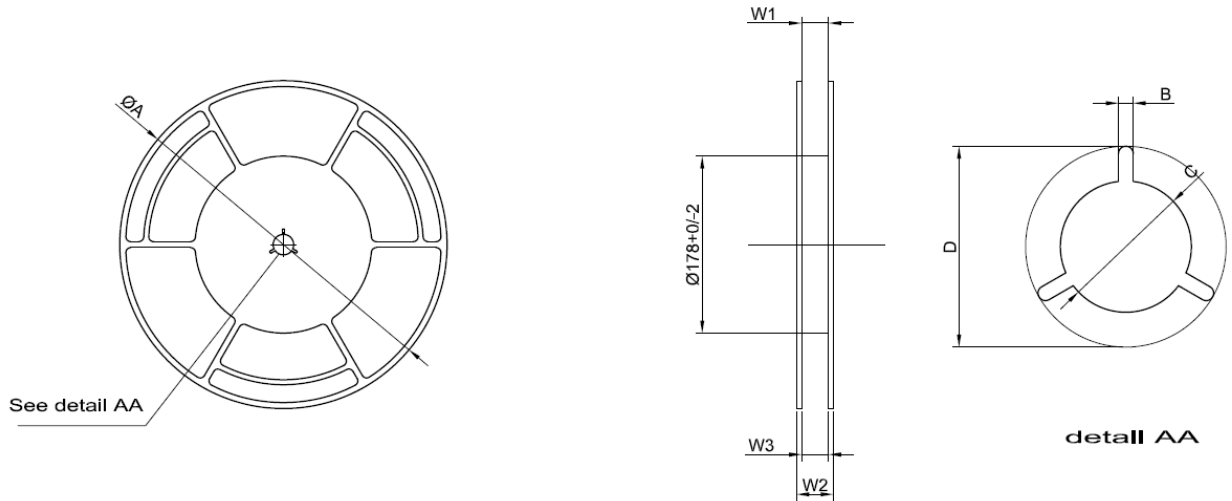


**Recommended Soldering Footprint**



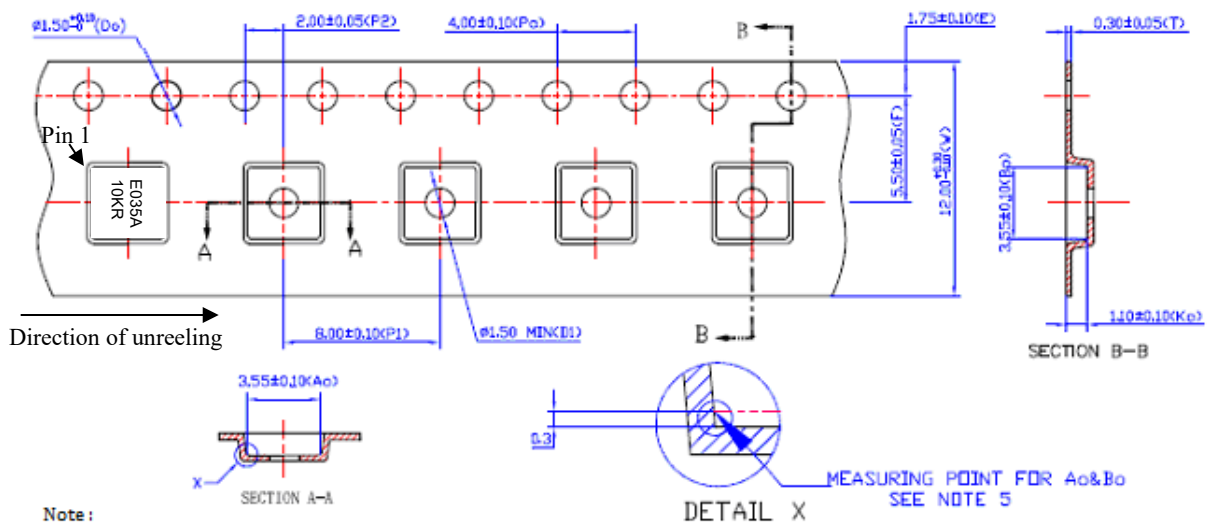
Unit : mm

### Reel Dimension



| TAPE SIZE | A       | B       | C           | D      | W1         | W2       | W3    |
|-----------|---------|---------|-------------|--------|------------|----------|-------|
| 12mm      | 330±2.0 | 2.9±0.5 | 13.0+0.5/-0 | 23±1.0 | 12.4 +2/-0 | 18.4±0.5 | 12~15 |

### Carrier Tape Dimension



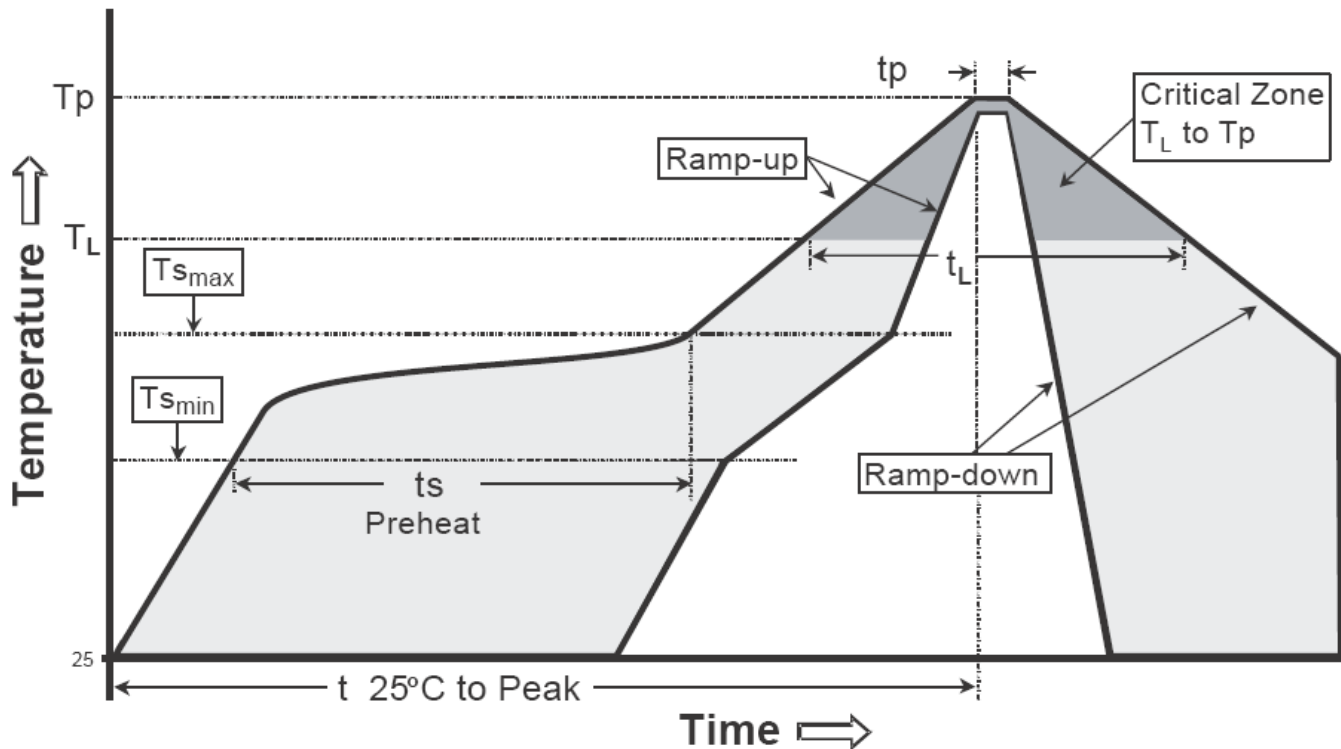
**Note :**

- 1.10 sprocket hole pitch cumulative tolerance : ±0.2mm.
- 2.Camber : Reference to carrier tape inspection manual.
- 3.Material : black conductive polystyrene.
- 4.All dimensions are in millimeters(unless otherwise specified).
- 5.Ao and Bo measured on a plane 0.3mm above the bottom of the pocket.
- 6.Ko measured from a plane on the inside bottom of the pocket to the top surface of the carrier.
- 7.Pocket position relative to sprocket hole measured as true position of the pocket, not pocket hole.
- 8.Surface resistivity : 1×10E4~1×10E11 ohms/sq

**Recommended wave soldering condition**

|                 |                  |                 |
|-----------------|------------------|-----------------|
| Product         | Peak Temperature | Soldering Time  |
| Pb-free devices | 260 +0/-5 °C     | 5 +1/-1 seconds |

**Recommended temperature profile for IR reflow**

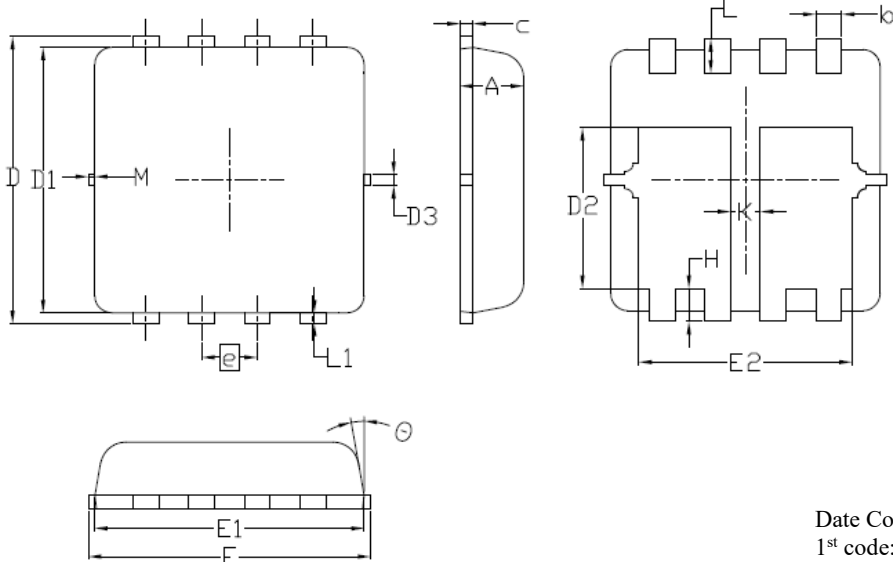


| Profile feature                                | Sn-Pb eutectic Assembly | Pb-free Assembly |
|--|-------------------------|------------------|
| Average ramp-up rate (Tsmmax to Tp)            | 3°C/second max.         | 3°C/second max.  |
| Preheat  |                         |                  |
| -Temperature Min(Ts min)                       | 100°C                   | 150°C            |
| -Temperature Max(Ts max)                       | 150°C                   | 200°C            |
| -Time(ts min to ts max)                        | 60-120 seconds          | 60-180 seconds   |
| Time maintained above:                         |                         |                  |
| -Temperature (Tl)                              | 183°C                   | 217°C            |
| - Time (tl)                                    | 60-150 seconds          | 60-150 seconds   |
| Peak Temperature(Tp)                           | 240 +0/-5 °C            | 260 +0/-5 °C     |
| Time within 5°C of actual peak temperature(tp) | 10-30 seconds           | 20-40 seconds    |
| Ramp down rate                                 | 6°C/second max.         | 6°C/second max.  |
| Time 25 °C to peak temperature                 | 6 minutes max.          | 8 minutes max.   |

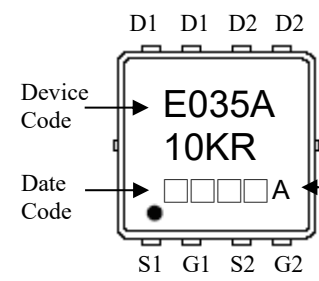
Note : All temperatures refer to topside of the package, measured on the package body surface.



**DFN3x3 Dimension**



**Marking:**



Device Code → **E035A**  
**10KR**  
 Date Code → [ ] [ ] [ ] [ ] **A**  
 Assembly site code → [ ] [ ] [ ] [ ]

**8-Lead DFN3x3 Plastic Package**  
 CYStek Package Code: V8

Date Code(counting from left to right) :  
 1<sup>st</sup> code: year code, the last digit of Christian year  
 2<sup>nd</sup> code : month code, Jan→A, Feb→B, Mar→C,  
 Apr→D, May→E, Jun→F, Jul→G, Aug→H,  
 Sep→J, Oct→K, Nov→L, Dec→M  
 3<sup>rd</sup> and 4<sup>th</sup> codes : production serial number, 01~99

| DIM | Millimeters |      | Inches |       | DIM   | Millimeters |      | Inches |       |
|-----|-------------|------|--------|-------|-------|-------------|------|--------|-------|
|     | Min.        | Max. | Min.   | Max.  |       | Min.        | Max. | Min.   | Max.  |
| A   | 0.70        | 0.80 | 0.028  | 0.031 | E2    | 2.39        | 2.59 | 0.094  | 0.102 |
| b   | 0.25        | 0.35 | 0.010  | 0.014 | e     | 0.65        | BSC  | 0.026  | BSC   |
| c   | 0.10        | 0.25 | 0.004  | 0.010 | H     | 0.30        | 0.50 | 0.012  | 0.020 |
| D   | 3.25        | 3.45 | 0.128  | 0.136 | L     | 0.30        | 0.50 | 0.012  | 0.020 |
| D1  | 3.00        | 3.20 | 0.118  | 0.126 | L1    | 0.13        | TYP  | 0.005  | TYP   |
| D2  | 1.78        | 1.98 | 0.070  | 0.077 | K     | 0.30        | -    | 0.012  | -     |
| D3  | 0.13        | TYP  | 0.005  | TYP   | theta | -           | 12°  | -      | 12°   |
| E   | 3.00        | 3.40 | 0.118  | 0.134 | M     | -           | 0.15 | -      | 0.006 |
| E1  | 3.00        | 3.20 | 0.118  | 0.126 |       |             |      |        |       |

**Notes:** 1.Controlling dimension: millimeters.  
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.  
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

**Material:**

- Lead: pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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